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September 29, 2000

**BOX PCT**

Assistant Commissioner
 for Patents
 Washington, D.C. 20231

PCT/FI99/00288 - filed
 April 6, 1999

Re: Application of **Markku RÄSÄNEN**,
Leonid KHRIACHTCHEV and **Mika PETTERSON**
 entitled "**METHOD AND APPARATUS FOR**
ANALYSIS OF GAS COMPOSITIONS"
Our Ref: Q-61067

Dear Sir:

The following documents and fees are submitted herewith in connection with the above application for the purpose of entering the National stage under 35 U.S.C. § 371 and in accordance with Chapter II of the Patent Cooperation Treaty:

- an executed Declaration and Power of Attorney.
- the International Application (in English).
- 2 sheets of drawings.
- an English translation of Article 19 claim amendments.
- an International Preliminary Examination Report.
- an executed Assignment and PTO 1595 form.
- a Form PTO-1449 listing the ISR references and a complete copy of each reference.
- Written Opinion.
- a Preliminary Amendment.

The Declaration and Power of Attorney, Assignment, International Preliminary Examination Report, Form PTO-1449 listing the International Search Report (ISR) references and a complete copy of each reference will be submitted at a later date.

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Assistant Commissioner
of Patent

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Priority is claimed from April 3, 1998, based on Finnish Patent Application No. 980781.

The Government filing fee is calculated as follows:

Total claims	<u>30</u>	-	<u>20</u>	=	<u>10</u>	x	\$18.00	=	<u>\$180.00</u>
Independent claims									
Base Fee	<u>3</u>	-	<u>3</u>	=	<u>0</u>	x	\$78.00	=	<u>\$0.00</u>
Multiple Dependent Claim Fee									
							<u>\$840.00</u>		
							<u>\$0.00</u>		
TOTAL FEE							<u>\$1020.00</u>		

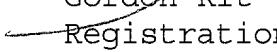
A check for the statutory filing fee of \$1020.00 will be submitted shortly.

The Assistant Commissioner is hereby directed and authorized to charge or credit any difference or overpayment to Deposit Account No. 19-4880.

The Assistant Commissioner is also hereby authorized to charge any fees under 37 C.F.R. §§ 1.16, 1.17 and 1.492 which may be required during the entire pendency of the application to Deposit Account No. 19-4880. A duplicate copy of this transmittal letter is attached.


Respectfully submitted,

Gordon Kit


Registration No. 30,764

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Date: September 29, 2000

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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

MARKKU RÄSÄNEN et al

CHAPT II filing

Appln. No.: of PCT/FI99/00288

Group Art Unit: 0000

Filed: September 29, 2000

Examiner: Unknown

For: METHOD AND APPARATUS FOR ANALYSIS
OF GAS COMPOSITIONS

PRELIMINARY AMENDMENT

Assistant Commissioner
of Patents
Washington, D.C. 20231

Sir:

Prior to examining the above-identified application, please amend the application as follows.

IN THE SPECIFICATION:

Page 1, line 5, insert

-- This application is a 371 of PCT/FI99/00288 filed April 6, 1999. --

IN THE CLAIMS:

Please amend the claims as follows:

Claim 5, line 1, change "any of claims 1 to 4" to
-- Claim 1 --.

Claim 6, line 1, change "any of claims 1 to 5" to
-- Claim 1 --.

Claim 7, line 1, change "any claim 1 to 6" to --Claim 1--.

Claim 8, line 1, delete "or 7".

PRELIMINARY AMENDMENT
CHAPTER II Filing
of PCT/FI99/00288

Claim 15, line 1, change "any of claims 11 to 14" to
-- Claim 11 --.

Claim 18, line 1, change "any of claims 15 to 17" to
-- Claim 15 --.

Claim 20, line 1, change "any of claims 11 to 19" to
-- Claim 11 --.

Claim 21, line 1, change "any of claims 11 to 20" to
-- Claim 11 --.

Claim 24, line 1, change "any of claims 21 to 23" to
-- Claim 21 --.

Claim 25, line 1, change "any of claims 11 to 24" to
-- Claim 11 --.

Claim 26, line 1, change "any of claims 11 to 25" to
-- Claim 11 --.

IN THE ABSTRACT:

Please insert the Abstract attached hereto.

REMARKS

The specification has been amended to insert formal matter, the claims have amended to delete their multiply dependency and the Abstract has been inserted in order to make the application consistent with U.S. patent practice. Hence, the amendment of the specification and claims and the addition of the Abstract does not constitute new matter.

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PRELIMINARY AMENDMENT
CHAPTER II Filing
of PCT/FI99/00288

The Examiner is invited to contact the undersigned at his Washington telephone number on any questions which might arise.

Respectfully submitted,

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Date: September 29, 2000

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ABSTRACT OF THE DISCLOSURE

A non-invasive portable apparatus for analyzing the performance of gas-filled window glazing units is disclosed. The operation of the apparatus is based on discharging the spacing between the panels (2a, 2b) of the window glazing unit (1) by applying rapidly alternating electrical field to the spacing between the panels of the window glazing unit, on collecting and analyzing the emitted discharge light in different structural intervals. The discharge is created by a needle-like electrode (5), and the inner conducting layer (2a) of the glazing unit serves as another electrode. The localization of the discharge in the vicinity of the end of the needle-like electrode (5) makes it possible to collect the emitted light without routine adjustment of the optical system. In this case, factory-adjusted lenses (4a) can be used to collect the light from the discharge, and the collected light can be transported to light detectors (9a-9d) by using fiber optics (6), which eliminates influence of instability to the discharge geometry.

Applicant or
Patentee: Markku RÄSÄNEN, Leonid KHRIACHTCHEV,
Mika PETTERSON

Application or
Patent No.: 09/647,458

Filed or Issued:
For: September 29, 2000

Attorney's
Docket No.: Q-61067

METHOD AND APPARATUS FOR ANALYSIS OF GAS COMPOSITIONS

**VERIFIED STATEMENT (DECLARATION) CLAIMING
SMALL ENTITY STATUS (37 CFR 1.9(f) and 1.27 (c)) --**

NONPROFIT ORGANIZATION

I hereby declare that I am an official empowered to act on behalf of the nonprofit organization identified below:

NAME OF ORGANIZATION HELSINKI UNIVERSITY LICENSING LTD. OY
ADDRESS OF
ORGANIZATION Viikinkaari 6, FIN-00710, Helsinki, FINLAND

TYPE OF ORGANIZATION

- University or other institution of higher education
 Tax exempt under Internal Revenue Service Code (26 USC 501(a) and 501(c) (3))
 Nonprofit scientific or educational under statute of state of The United States of America
(Name of State) _____
(Citation of statute) _____
 Would qualify as tax exempt under Internal Revenue Service Code (26 USC 501(a) and 501(c) (30)) if located in
The United States of America
 Would qualify as nonprofit scientific or educational under statute of state of The United States of America if located in
The United States of America
(Name of State) _____
(Citation of statute) _____

I hereby declare that the above nonprofit organization identified above qualifies as a nonprofit organization as defined in 37 CFR 1.9(e) for purposes of paying reduced fees under section 41(a) and (b) of Title 35, United States Code with regard to the invention entitled: **METHOD AND APPARATUS FOR ANALYSIS OF GAS COMPOSITIONS** by inventors **Markku RÄSÄNEN, Leonid KHRIACHTCHEV and Mika PETTERSON**

Described in the specification filed herewith
 application no. 09/647,458 filed September 29, 2000
 patcnt no. _____ issued _____

I hereby declare that rights under contract or law have been conveyed to and remain with the nonprofit organization with regard to the above identified invention.

If the rights held by the nonprofit organization are not exclusive, each individual, concern or organization having rights to the invention is listed below* and no rights to the invention are held by any person, other than the inventor, who could not qualify as a small business concern under 37 CFR 1.9(d) or by any concern which would not qualify as a small business concern under 37 CFR 1.9(d) or a nonprofit organization under 37 CFR 1.9(e).

*NOTE: Separate verified statement are required from each named person, concern or organization having rights to the invention averring to their status as small entities. (37 CFR 1.27)

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ADDRESS _____

INDIVIDUAL

SMALL BUSINESS
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I acknowledge the duty to file, in this application or patent, notification of any change in status resulting in loss of entitlement to small entity status prior to paying, or at the time of paying, the earliest of the issue fee or any maintenance fee due after the date on which status as a small entity is no longer appropriate. (37 CFR 1.28(b))

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code, and that such willful false statements may jeopardize the validity of the application, any patent issuing thereon, or any patent to which this verified statement is directed.

NAME OF PERSON SIGNING Eija Pöytäkivi

TITLE IN ORGANIZATION MANAGING DIRECTOR

ADDRESS OF PERSON SIGNING VIIKINKAARI 6, FIN-00710 Helsinki, FINLAND

Signature G. Pöytäkivi Date November 28, 2000

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METHOD AND APPARATUS FOR ANALYSIS OF GAS COMPOSITIONSBackground of the Invention

5

Field of the Invention

The present invention relates to spectroscopic analysis of gas compositions in sealed containers. More specifically, the invention relates to a non-invasive method for selectively analysing gas-mixtures enclosed in a spacing between two glass sheets, such as between the panels of a window glazing unit. The present invention also concerns a modular, portable apparatus for analyzing the performance of gas-filled window glazing units.

Description of Related Art

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Filling gases with low thermal conductivity, e. g. argon, krypton and xenon, as well as low emissivity coatings are used for a considerable reduction of heat transfer in window glazing units. The performance of the glazing units dramatically depends on the gas present in the spacing. For example, xenon and krypton provide much better insulation than argon. Also, as the rim seal is not perfectly leak tight, part of the filling gas can diffuse out and air can diffuse into the spacing, resulting in decreasing insulation performance. In order to predict the storage and operating lifetimes, there is a need for precise analysis of the gas mixture composition during manufacturing, storage and use. When the window fillings of existing constructions are to be tested, the movability of the measuring unit is of great importance.

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Known gas analyzers employing mass-spectrometry and gas-chromatography are not suitable because they require physical contact with analyzed gas volume. Methods based on infrared and Raman spectroscopy are not applicable in the case of noble gas atoms because they essentially probe vibrational frequencies of molecules. Laser spectroscopic methods are not suitable because of complicated and expensive equipment employed. Direct measurements of the absorption spectra are also impossible to utilize in movable

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devices because the absorption lines of the noble gases occupy the vacuum ultraviolet spectral region not transmitted by the window glazing panels.

There are a number of known methods for spectroscopically analyzing the performance of gas-filled electronic lamps. In particular, a method utilizing optogalvanic phenomenon (US Patent No. 4,939,926) has been suggested for determining the performance of sealed rf discharged lamps at low pressure. The known method cannot be directly utilized for atmospheric pressure windows. In an embodiment described in the patent, a broad band ultraviolet-visible source is employed, which prevents the use of the method for selective measurements. In order for the optogalvanic approach to provide selectivity, a high-intensity tunable laser source should be used, which prevents the method from coming to portable realization.

DE Published Patent Application No. 195 05 104 discloses a method and an arrangement for testing the purity and pressure of gases for electrical lamps. For the measurements both pressure dependent and independent emission lines are obtained. The prior art technology is designed for detection of impurities in electronic lamps, especially in those filled with noble gases. An external hf-excitation source with one electrode is used, and the lamp electrode acts as the other electrode. As regards the discharge excitation, the device is not suitable for atmospheric-pressure sealed containers because the measurement of argon pressure is insensitive when the pressure exceeds 10 kPa. Discharge in extensive volume requires high power of the source which means that portable realization is problematic.

A non-invasive pressure measuring device described in US Patent No. 5,115,668 is used for estimating the luminance of an externally induced, high-frequency glow discharge of a gas in a lamp. Comparison of the measured luminance with calibrated luminance vs. pressure data provides the pressure for the gas. The device employs an indirect method for pressure dependence of the luminance without any normalizing procedure, which makes it sensitive to geometrical re-arrangement so that the device is not really transportable. The method uses stable rf excitation and applies to a narrow field of application, i. e., low-pressure lamps, and it cannot be applied to atmospheric pressure sealed containers. The device measures the light in integral without wavelength analysis which means that it

is not selective to different elements.

US Patent No. 5,570,179 discloses a measuring sensor and a measuring arrangement for use in the analysis of gas mixture, consisting of a chamber with transparent window(s) and arranged gas flow, two electrodes on the opposite side of the chamber to apply high alternating voltage to the gas flow, and light detector(s) to measure the intensity of radiation emitted through the chamber window in some selected spectral region. The device is designed mainly for surgical use in hospitals. The method is not non-invasive so that it is not applicable for sealed containers like gas-filled window glazing units. The use of two electrodes is impossible in a window units possessing an inner conducting layer.

There are a number of methods and devices specially created for estimating the performance of window glazing units. A known chemical gas monitor for detecting a leak of the window panel (cf. US Patent No. 4,848,138) uses chemicals, which are reactive with the constituents of air but not reactive with noble gases. The method requires special reconstruction of the window because the virtual chemical must be inserted during window manufacturing, and it cannot be used for existing constructions.

A known non-destructive method for determination of the rare-gas content of highly insulating glazing units (DE Published Patent Application No. 195 21 568.0) allows for the determination of the leak of air into the window spacing, at least, for krypton and xenon. The determination of the relative amount of the noble gas is based upon measuring the sound velocity in the gas filling. The method is, however, mainly applicable to stationary measurements because it requires precise control of measurement condition (temperature, spacing distance, etc.), which makes any portable realization very questionable and field measurements impossible. Also, the method is insensitive to argon filling, which is the most important in the area. The method is inselective to different noble gases so that it is unable to distinguish, for example, a mixture of krypton with air from proper filling with argon.

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To complete the survey of related art, a method of determining the percentage gas content of an insulating glass window unit is known from US Patent No. 5,198,773. The prior

method is based on applying a voltage to opposite panes of the unit, progressively increasing the voltage, monitoring the voltage, recording the value of threshold discharge voltage, and converting the magnitude to percentage gas content between the panes. The method is directed to recognizing the percentage content of some given gas (e. g. argon or sulfur hexafluoride) between gas panel, and it is impossible to apply it for a window unit of unknown filling. In other words, the prior method is not selective to different noble gas fillings. Also, the necessary use of two electrodes prevents the method from measuring units with conducting inner layers, which are commonly used now to improve insulation performance of the production.

10

Summary of the Invention

It is an object of this invention to eliminate the problems relating to the prior art and to provide a novel method for selective identification of gas components present in a gas or gas mixture.

It is another object of the invention to provide a compact, easily movable and inexpensive device, which is suitable for selective identification of gas components typical for insulation window glazing units, i. e., argon, krypton, xenon and air.

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These and other objects, together with the advantages thereof over known processes, which shall become apparent from specification which follows, are accomplished by the invention as hereinafter described and claimed.

25

The present invention is based on the concept of discharging the spacing between the panels of the window glazing unit by applying rapidly alternating electrical field to the spacing between the panels of the window glazing unit. To achieve a discharge, a grounded counter-electrode is used. In particular, the present invention comprises creating a local excitation of the gas in a glazing unit by using an electrode, while the inner conducting layer of the glazing unit may serve as the counter-electrode. The emitted light of the discharge is collected from a collection area larger than the emission area, analyzed in different spectral intervals and the concentration of a gas of interest is calculated by

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comparing the intensity of a spectral interval corresponding to said gas with the intensity of another interval.

The localization of the discharge in the vicinity of the end of an electrode having a small
5 end (e.g. a needle-like electrode) allows for collection of the emitted light without routine
adjustment of the optical system.

According to the present invention, the apparatus for non-invasive analysis of, e.g., gas-filled window glazing units comprises means for locally applying the rapidly alternating
10 high voltage to the spacing of the window glazing unit to achieve local emission and means
for collecting and transporting emitted light. Further, there are means for determining the
intensity of at least two different spectral intervals, at least one of which corresponds to the
gas component of interest, and means for calculating the ratio between the intensities of the
different spectral intervals.

15 More specifically, the non-invasive method according to invention is mainly characterized
by what is stated in the characterizing parts of claims 1 and 10.

20 The apparatus according to the invention is characterized by what is stated in the
characterizing part of claim 11.

25 Considerable advantages are achieved by the invention. Thus, factory-adjusted lenses can
be used to collect the light from the discharge, and the collected light can be transported to
light detectors by using fiber optics, which eliminates influence of instability of the
discharge geometry.

According to a preferred embodiment, a modular apparatus is provided, in which the
electrode used for local application of rapidly alternating high voltage to the spacing of the
window glazing unit and the lens or mirror used for collecting the emitted light are
30 arranged in one portable unit (remote sensor unit) which easily can be transported to the
vicinity of the glazing unit which is to be tested. The remaining part of the apparatus can be
mounted into a, likewise movable, separate processing unit. If desired, the remote sensor

unit can further be provided with means for displaying the obtained information about the performance of the window glazing unit, so as to provide the person testing the window to obtain the necessary data for evaluating the performance of the window. An additional light detector can also be fitted in the remote sensor unit and connected to the processing means with an additional electrical line, a high alternating voltage being automatically applied to a sample container in absence of a discharge through the window glazing unit.

The movability of the device means that it is possible to use it in field to analyze gas components inside window units installed in real buildings, not only during the manufacturing of window glazing units. The selectivity of the device to the gas components means that it distinguishes between the components without information about the gas filling obtained *a priori*. The device probes the gas components at normal atmospheric pressure. In order to estimate the operation quality of the window units, the device is capable of recognizing a window unit with more than a specified concentration (e.g. 10 %) of air in addition to a filled noble gas. For determining the performance of the window unit, the device is further capable of discriminating between different possible noble gases (argon, krypton, xenon). In other words, the device is capable of analyzing the gas composition when the gases are argon, krypton, xenon, and air.

Next the invention will be examined in more closely with the aid of a detailed description with reference to the attached drawings.

Brief Description of the Drawings

Fig. 1 is a schematic illustration of one embodiment of the non-invasive device for analyzing the performance of gas-filled window glazing units;
Fig. 2a presents the correlation between the amount of air in the window and the intensity ratio $R_1 = I(402-408)/I(694-699)$; and
Fig. 2b displays the air-concentration dependence of the parameter $R_2 = I(748-753)/I(694-699)$ employing Ar lines only where the numbers in parenthesis denote the spectral interval in nanometers.

Detailed Description of the Invention

The following description will examine the invention when used in connection of a gas-filled window glazing unit. It should be pointed out that the invention is, however, more generally applicable to any closed spacings having at least one wall of a transparent or even translucent material. It is required that the material has dielectric properties (rather than conducting properties) to allow for the creation of a discharge by high voltage. Further it is required that the transparent or translucent material allows for transmission of enough emitted light to make spectral recognition possible.

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The operation of the non-invasive device according to the present invention is based on discharging the spacing between the window panels of a glazing unit by applying rapidly alternating electrical field, collecting and analyzing the emitted light in different spectral intervals in comparison with another spectral interval or with the integral value of the emittance. Rapidly alternating electrical field is known to produce mainly excitation of neutral particles, and ionization as well as dissociation are of minor importance. In discharge, the excited atoms and molecules emit light which is collected and analyzed.

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The spectral properties of the emitted light reflect the gas composition in the discharged spacing. In particular, there are a number of known characteristic lines for different elements, and they can be chosen, for example, as 812 nm for argon, 587 nm for krypton, and 467 nm for xenon. These characteristic lines are well separated from each other so that they can be selected by ordinary interference filters. Molecular species, which are specific for air, emit vibrationally structured spectrum, in much broader spectral interval, and they provide mainly emittance signal in integral when no spectral selection is used. These dramatic spectral differences in emission of the species of interest construct the fundamental basis for the invention. By comparing the intensities emitted in different spectral intervals with the the intensity of another spectral interval or with the integral intensity the gas composition in the discharged volume can be extracted.

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30 The present device can be calibrated by creating a correlation between the discharge spectra and gas-mixture concentration. The concentration inside a sample window unit can

be prepared using, e.g. a multi-channel gas-flow meter. Correlation curves, such as those shown in Figures 2a and 2b, can be obtained as explained in connection with the Example below. Thus, in the present method, the spectrum of the discharge is measured to obtain numerical parameters, and then the gas mixture concentration can be determined from a calibration curve.

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In order to create the discharge, two electrodes, an internal (conducting layer of the window glazing unit), and external are used. As mentioned above, it is also possible to use a second external electrode as a counter electrode should the glazing unit not be provided with a conducting layer. An important feature of the invention comprises localization of the discharge, which is achieved by employing an electrode having a small area at least in two dimensions. Examples of such electrodes are electrodes having an elongated body with a tapered end. The size of the end is preferably less than 10 mm, in particular about 1 mm in diameter. Other examples are conductive layers having a corresponding small area. Such conductive layers can be deposited on the surface of the lens used for collecting the emission. In this case, the discharge starts in the vicinity of the end of the electrode. This localization allows reliable collecting the emitted light to be provided without routine adjustment of the optical system. In the present invention, microlenses can be used to collect the light from the discharge, and the collected light can be transported to light detectors by using fiber optics. It is important that splitting the light to different beams is done after the optical fiber but not from the discharge, which eliminates any influence of natural instability of the discharge geometry.

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The processing of the spectral data obtained will be dealt with more closely in relation to the practical embodiment of Figure 1.

Within the scope of the present invention, the term "local" or "localized" discharge means that the discharge takes place in only a part of the closed spacing of interest. As a practical matter, the localized discharge means that the collection of the emission is carried out from a collecting area larger than the emission area.

The above embodiment describes using the integral intensity of the emission for

determining the concentration of a gas component of interest by forming the ratio of the intensity of a spectral interval corresponding to the gas component and the integral intensity. It should, however, be pointed out that the intensity of a spectral interval corresponding to another gas component or the intensity of a different spectral interval corresponding to the same gas component can be used for the same purpose. Thus, the method according to the present invention comprises the alternative of determining the intensity of a first spectral interval corresponding to the gas component of interest and the intensity of a second spectral interval, different from the first spectral interval, said second spectral interval corresponding to the integral emission, to the emission of another component of the gas mixture, or the emission of the same gas component.

Turning now to the embodiment depicted in Figure 1, it can be noted that the gas mixture 1 to be analyzed is kept inside the window glazing unit. The window glazing unit particularly contains two glazing panels 2a and 2b. The internal surface of one of the panels, specifically 2a, is covered by the layer, which conducts electrical current, and the other panel (2b) is free of conducting coating.

The non-invasive device depicted in the drawing for analyzing the performance of gas-filled window glazing units comprises a needle-like electrode 5 for applying rapidly alternating high voltage to the spacing of the window glazing unit, a lens 4a for collecting the emitted light, and an optical fiber 6 for transporting the collected light. These parts of the device can be fitted into a first module, which can be called a remote sensor unit 16. The device further comprises a processing unit (or measuring and displaying unit) 15 with a lens 4b for collimating the transported light, beam splitters 8a, 8b, 8c and 8d for splitting the collimated light beam, one normalizing light detector 9a for measuring a signal proportional to the integral discharge emittance, three component light detectors 9b, 9c and 9d with means 17b, 17c and 17d for spectral selection of different characteristic lines of gas components, data processing means 10b, 10c and 10d for comparing signals in the different channels to estimate gas composition in the window glazing unit, a processor 12, means 11 for detecting the existence of the discharge, means 13 for displaying the obtained information, means 7 for creating a rapidly alternating high voltage, and a switcher 14.

The apparatus is operated as follows. Rapidly alternating electrical field is applied to the window glazing unit from the side of the panel 2b by using the needle-like electrode 5. As the other electrode, the conducting layer of the panel 2a is used. The rapidly alternating electrical field produces a discharged channel in the spacing between the glazing panels, 5 and the discharge starts in the close vicinity to the end of the electrode 5. Emitted light is collected by a lens 4a. The end of the electrode 5 is located at about 0.5 to 3, preferably about two, focal distances of the lens 4a from the lens 4a. The collected light is directed into the optical fiber 6, the end "a" of which locates at about two focal distances from the lens 4a and about at a discharge-lens axis.

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The light, transmitted by the optical fiber 6 and emitted from the end "b" of the optical fiber 6, is then collimated by a lens 4b. The lens 4b is located at about 0.5 to 2, preferably about one focal distance from the end "b" of the optical fiber 6. Quasi-parallel light beam goes through a sequence of four beam splitters 8a, 8b, 8c, and 8d. Deflected beams are 15 directed onto light detectors 9a, 9b, 9c, and 9d. The light detector 9a measures intensity proportional to the integral intensity of the discharge. The light beams directed to light detectors 9b, 9c, and 9d are spectrally selected by spectral filters 17b, 17c, and 17d to measure signals proportional to gas component percentage. The electrical signal from the light detector 9a is applied to comparing units 10b, 10c and 10d to generate ratios of the 20 spectrally selected and integral signals. Also, the electrical signal from the light detector 9a is applied to a level unit "Yes-No" 11 to check the appearance of the electrical discharge 3 in the spacing of the window glazing unit. Electrical signals from the level unit "Yes-No" 11 and from the comparing units 10b, 10c and 10d are applied to a processor 12 to be analyzed. The result of the analysis by the processor 12 is shown at a display 13. In 25 particular, the following information is to be displayed: existence of the discharge, type of dominating filling (argon, krypton, xenon), percentage of the dominating filling. The alternating high voltage to apply to the electrode 5 is created by a high-voltage generator 7. The operation of the device is started and stopped by a switcher 14.

30 Although not shown in Figure 1, the measuring and displaying unit 15 is electrically supplied either from the electrical network or from a battery. The light detectors 9a, 9b, 9c, and 9d include corresponding pre-amplifiers (not depicted) to construct proper electrical

signals.

In addition to the numerous advantages of the invention explained above it should be pointed out in connection with the practical embodiment of Figure 1 that it removes the need for calibration of absolute luminescence flux because the device analyzes the ratios between fluxes in spectral interval with normalization by integral flux. Another important feature of the present embodiment is that there is no need in geometrical stability of the measurement because the device analyzes the ratios between fluxes in spectral interval with normalization by integral flux, and optical alignment with required accuracy is prepared at the manufacturing stage. Practically, this means the opportunity of movable performance of the device.

It is understood that many changes and additional modifications are possible in view of different versions of performance without departing from the scope of the inventions as defined in the appended claims. Thus, as explained in connection with the method, the means (9a) for measuring a signal proportional to the integral discharge emittance can be replaced with means for measuring a signal proportional to any spectral interval useful for the determination of the gas concentration of the gas of interest. A combination of the features of the claims produces additional advantages.

In particular, it is also possible to mount the means for displaying the obtained information about performance of the window glazing unit in the remote sensor unit formed by the means for locally applying rapidly alternating high voltage and the lens.

The means for measuring gas component signals can comprise a CCD camera.

As briefly discussed above, the apparatus can also contain a sample container for controlling the operational performance of the apparatus as a whole. The sample container is preferably installed into the remote sensor, which is provided with an additional light detector and connected with the data processing means, whereby the apparatus can be operated so that a high alternating voltage is automatically applied to the sample container in the absence of a discharge through the window glazing unit.

The means for splitting the collimated beam and spectrally selecting the characteristic lines can comprise a spectrometer.

Example

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A window-glazing unit with a spacing between the window frames of 12 mm and having a conductive selective coating on one side of the window was used for establishing a numerical correlation between emission from discharged air-Ar mixture and the relative gas concentration. The window was provided by VTT (Espoo, Finland) and it is similar to units manufactured in industry. The window spacing was flushed with an atmospheric-pressure mixture of Ar and synthetic air in well-defined proportions as measured by a gas-flow meter (Brooks, M0154+5850S). The spacing was discharged from the non-coated side by a Tesla generator. A plastic fiber optics (1 mm of thickness) transported the emission light to a spectrometer (Ocean Optics S2000, 1 nm of resolution) controlled by a portable computer. Basically, the experimental procedure corresponded to the scheme described above in connection with Figure 1. The discharged light collected by lens 4a transported through optical fiber 6 was conducted to the entrance or input channel of a spectrometer S2000 equipped with a CCD detector. The spectrometer with the CCD detector resembles the elements 8 (beam splitter), 9 (detector) and 17 (filters) disclosed in Figure 1. The signals from the CCD detector were analyzed by a computer, which gave functions 10 (comparing units), 11 (level unit), 12 (processing) and 13 (displaying).

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The device was calibrated by creating a correlation between the discharge spectra and gas-mixture concentration.

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It was found that a discharge through the window spacing was present for a 0 to 50 % range of relative concentration of air in the mixture, and the resulting emission spectra essentially depended on the Ar-air concentration ratio. When the relative concentration of air is small, the argon lines in the 690 to 800 nm region dominate in the spectrum. When the amount of air increases, emission lines from air grow occupying UV-visible region of the spectrum.

By normalizing the signals from air and Ar against integrated intensity it is possible to obtain empirical parameters connecting the relative concentrations with the shape of the measured spectra. Similar correlation curves can be obtained by comparing the ratio between line intensities of air and Ar with the relative concentrations. Figure 2 (a) presents such a correlation between the amount of air in the window and the intensity ratio $R_1 = I(402-408)/I(694-699)$ where numbers in parentheses give the integration interval in nanometers, the first intensity belonging to air and the second one originating from Ar emission. It is seen that the correlation function is straightforward and nearly linear.

10 Additionally, it appeared that the spectrum of Ar emission itself shows repeatable modifications when the amount of air changes. This effect arises from differences in properties of the emitting Ar levels (energy, lifetime, etc.), which influences partial energy flows from different Ar levels to air buffer. The air-concentration dependence of the parameter $R_2 = I(748-753)/I(694-699)$ employing Ar lines only is displayed in Figure 2 (b).

15 Thus, the correlation curves presented in Figure 2 allow for accurate extraction of relative Ar-air concentration from the discharge emission measured. An analysis shows that the accuracy of the estimate is better than 1 % in absolute concentration in the practically important region from 0 to 30 % of relative air concentration with the integration time below 1 sec. and both parameters R_1 and R_2 yield similar accuracy in this region. In the region from 30 % to 50 % of relative air concentration, the absolute accuracy decreased somewhat.

20 Also the correlation functions were tested for different positions of the optical fiber and various discharge voltages (three different Tesla generators) and they were shown to be practically independent of these parameters. Also, the method was successfully tested for Kr-air mixtures.

Claims:

1. A non-invasive method for selectively determining the concentration of at least one gas component in a gas mixture contained in a closed spacing (1) having at least one transparent, dielectric wall (2a, 2b), comprising:
 - locally applying rapidly alternating high voltage to the spacing to provide localized light emission (3) in an emission area;
 - collecting emitted light of the local emission (3) from a collection area larger than the emission area;
 - determining the intensity of at least two different spectral intervals, at least one of which corresponds to the gas component of interest;
 - calculating the ratio between the intensities of two spectral intervals, one of which corresponds to the gas component of interest; and
 - determining the concentration of the gas component of interest from said ratio.
2. The method according to claim 1, wherein the spacing (1) comprises two glass walls formed by two glass sheets (2a, 2b) spaced apart from each other.
3. The method according to claim 2, wherein the spacing comprises a gas-filled window glazing unit (1).
4. The method according to claim 1, wherein a grounded counter-electrode is used.
5. The method according to any of claims 1 to 4, wherein alternating high voltage is applied to the closed spacing using an elongated electrode (5) having a tapered end and by directing said end of the electrode against the closed spacing.
6. The method according to any of claims 1 to 5, wherein the light of the local emission is collected with a lens (4a) to provide a collimated light beam, said lens being located at a distance of about 0.5 to 3 focal distances from the site of the local emission.
7. The method according to any claim 1 to 6, comprising determining the intensity of a

first spectral interval corresponding to the gas component of interest and the intensity of a second spectral interval, different from the first spectral interval, said second spectral interval corresponding to the integral emission, to the emission of another component of the gas mixture, or the emission of the same gas component.

- 5 8. The method according to claim 6 or 7, wherein the collimated light beam is split to provide a first split beam having a signal proportional to the integral discharge emittance and a second beam which is used for measuring a signal dependent on the concentration of one gas component, said split signals being subjected to spectral filtration to measure
10 signals dependent on specific gas components.
- 15 9. The method according to claim 8, wherein the collimated light beam is split to provide at least one further split signal used for measuring signals proportional to the concentration of at least one further gas component.
- 20 10. A non-invasive method for selectively determining the concentration of at least one gas component in a gas mixture contained in a closed spacing (1) having at least one transparent, dielectric wall (2a, 2b), comprising:
25 – locally applying rapidly alternating high voltage to the spacing to provide localized light emission (3) in an emission area;
 – collecting emitted light of the local emission (3) from a collection area larger than the emission area;
 – determining the integral intensity of the emission;
 – determining the intensity of a spectral interval corresponding to the gas component of interest;
 – calculating the ratio between the intensity of the spectral interval and the integral value of the intensity; and
 – determining the concentration of the gas component from said ratio.
- 30 11. An apparatus for non-invasive analysis of gas-filled window glazing units (1) for determining the performance thereof, comprising:
 – means (7) for creating rapidly alternating high voltage,

- means (5) for locally applying the rapidly alternating high voltage to the spacing of the window glazing unit to achieve local emission;
- means (4a, 6, 4b) for collecting and transporting emitted light;
- means (9a to 9d) for determining the intensities of at least two different spectral intervals, at least one of which corresponds to the gas component of interest;
- means (10b-10d) for calculating the ratio between the intensities of two spectral intervals, one of which corresponds to the gas component of interest; and
- means (12) for determining the concentration of the gas component from said ratio.

- 5 12. The apparatus according to claim 11, wherein the means for locally applying rapidly alternating high voltage comprise a needle-like electrode (5).
- 10 13. The apparatus according to claim 11, wherein the means for locally applying rapidly alternating high voltage comprise a conductive layer coated on the means for collecting the emitted light, which can be used as an electrode.
- 15 14. The apparatus according to claim 11, wherein the apparatus contains a second electrode, which can be grounded and set on the opposite side of the window unit.
- 20 15. The apparatus according to any of claims 11 to 14, wherein the means for collecting and transporting the emitted light comprise a collecting lens (4a) which can be brought in the vicinity of the closed spacing.
- 25 16. The apparatus according to claim 15, wherein the means for collecting and transporting the emitted light further comprise optical fibres (6) for transporting the light and a collimating lens (4b) for collimating the light transported by the optical fibres.
- 30 17. The apparatus according to claim 16, wherein the optical fiber (6) comprises optical connectors for connecting to the collecting lens (4a), to the collimating lens (4b) and/or to another optical fiber.
18. The apparatus according to any of claims 15 to 17, wherein the means for collecting

and transporting the emitted light (4a, 6, 4b) are formed as a single non-adjustable block (16).

19. The apparatus according to claim 15, wherein the means (5) for locally applying rapidly alternating high voltage and the lens (4a) are fitted together to form a separate sensor unit.

20. The apparatus according to any of claims 11 to 19, comprising means (8a-8d) for splitting the collimated light into a first splitted beam having a signal proportional to the integral discharge emittance and at least one second beam for measuring a signal proportional to the concentration of one gas component.

21. The apparatus according to any of claims 11 to 20, wherein the means for determining the intensity of the spectral interval corresponding to the gas component of interest comprise light detectors (9b-9d) with means (17b-17d) for spectral selection of different characteristic lines of gas components.

22. The apparatus according to claim 21, wherein the means for spectral selection comprise interference filters (17b-17d).

23. The apparatus according to claim 22, wherein the interference filters (17b-17d) have central wave lengths at 467 nm, 587 nm and/or 812 nm.

24. The apparatus according to any of claims 21 to 23, wherein the means for measuring gas component signals are performed as a CCD camera.

25. The apparatus according to any of claims 11 to 24, wherein the apparatus contains a sample container for controlling the operational performance of the apparatus as a whole.

26. The apparatus according to any of claims 11 to 25, further comprising
- data processing means (12) for comparing signals in order to estimate gas composition in the window glazing unit; and

- means (13) for displaying the obtained information.

27. The apparatus according to claim 26, wherein the means for splitting the collimated beam and spectrally selecting the characteristic lines comprise a spectrometer.

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28. The apparatus according to claim 27, wherein the means (13) for displaying the obtained information about performance of the window glazing unit is mounted in the remote sensor unit (16) formed by the means for locally applying rapidly alternating high voltage and the lens.

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29. The apparatus according to claim 28, wherein the sample container is installed into the remote sensor (4a, 6, 4b), which is provided with an additional light detector and connected with the data processing means (12), whereby the apparatus can be operated so that a high alternating voltage is automatically applied to the sample container in the absence of a discharge through the window glazing unit.

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30. The apparatus according to claim 11, comprising means (9a) for determining the integral intensity of the emission and means (9b-9d) for determining the intensity of at least one spectral interval corresponding to the gas component of interest;

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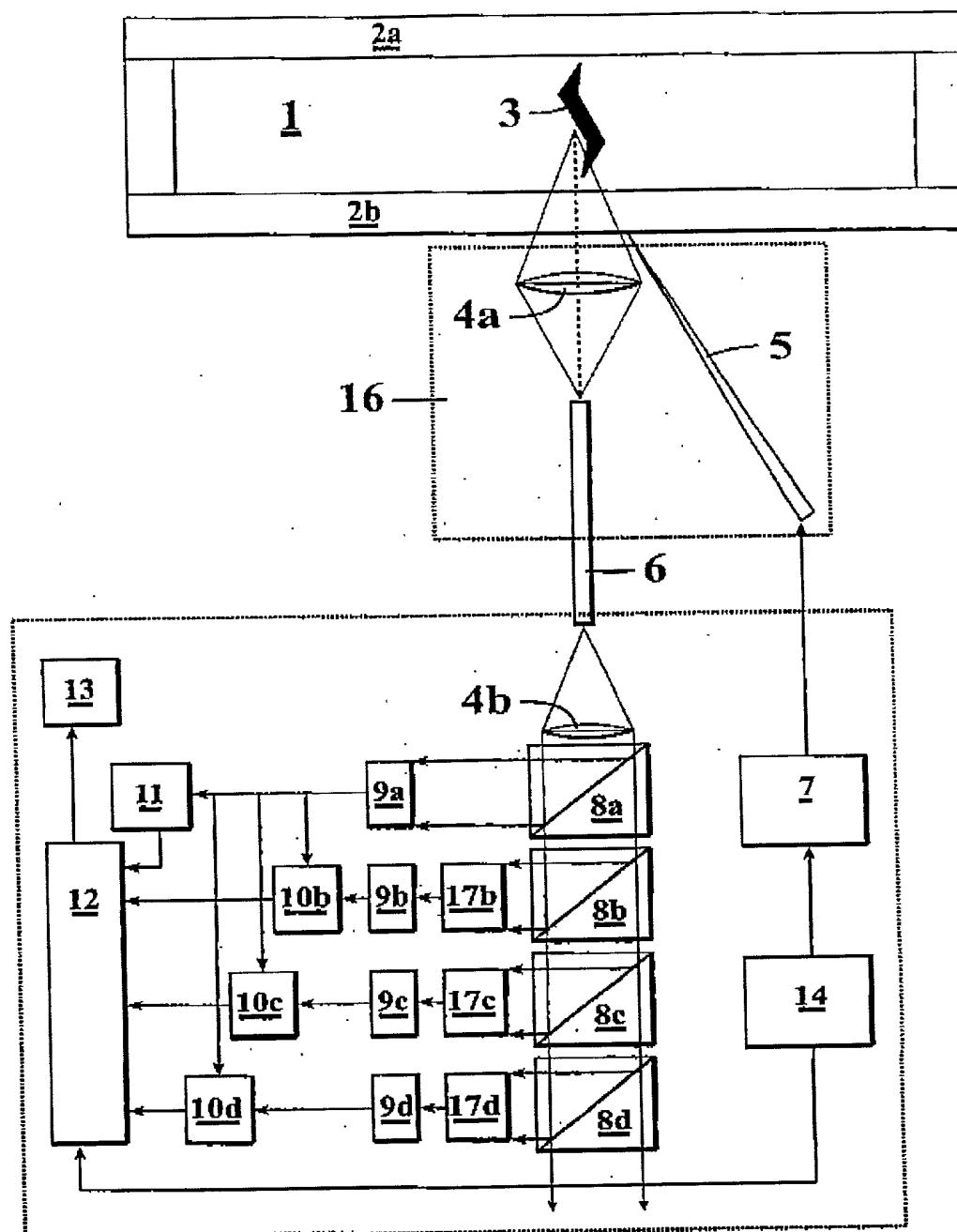
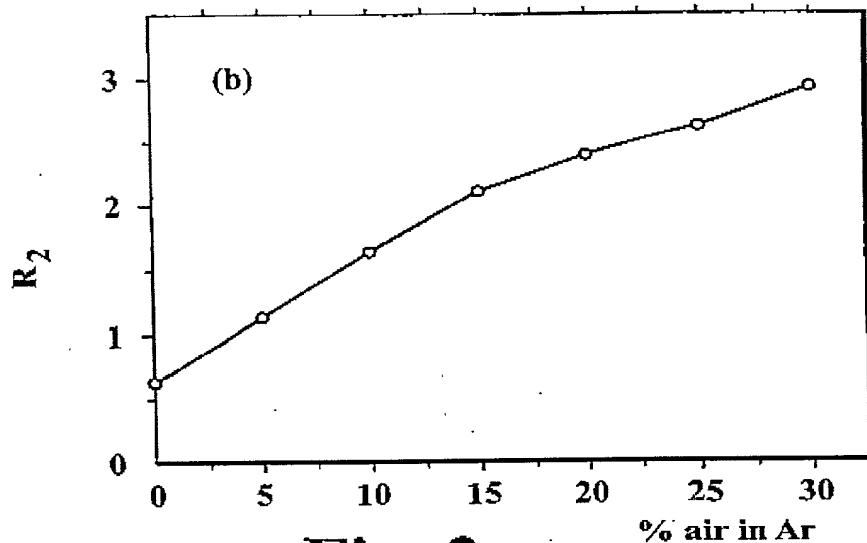
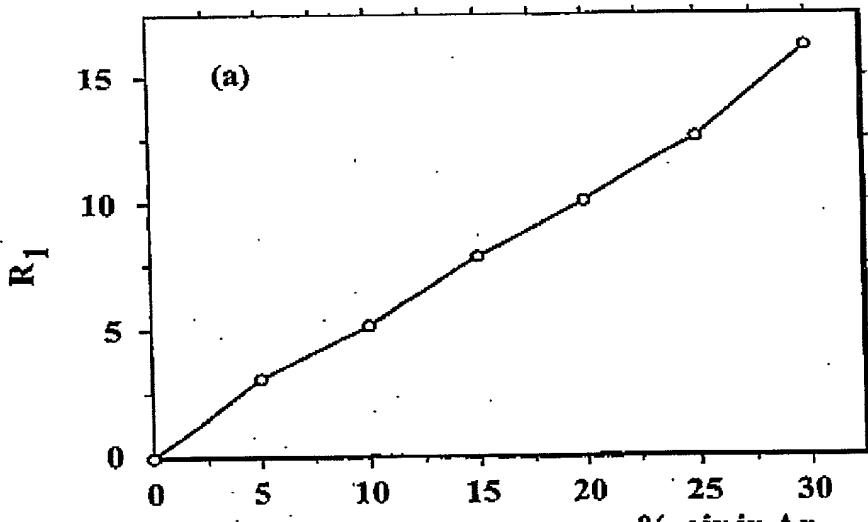


Fig. 1

SUBSTITUTE SHEET (RULE 26)

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**Fig. 2a****Fig. 2b**

DECLARATION AND POWER OF ATTORNEY

As the below named inventors, we hereby declare that our residence, post office address and citizenships are as stated below next to our names: that we verily believe we are the original and joint inventors of the subject matter claimed and for which a patent is sought in the application entitled:

METHOD AND APPARATUS FOR ANALYSIS OF GAS COMPOSITIONS

which application is:

the attached application
(for original application)

Application No. 09/647,458

filed September 29, 2000, and amended on

September 29, 2000

(for declaration not accompanying application)

that we have reviewed and understand the contents of the specification of the above-identified application, including the claims, as amended by any amendment referred to above; that we acknowledge our duty to disclose information of which we are aware which is material to the patentability of this application under 37 C.F.R. § 1.56, that we hereby claim priority benefits under Title 35, United States Code §119, §172 or §365 of any provisional application or foreign application(s) for patent or inventor's certificate listed below and have also identified on said list any foreign application for patent or inventor's certificate on this invention having a filing date before that of any foreign application on which priority is claimed:

Application Number	Country	Filing Date	Priority Claimed
PCT/FI99/00288 980781	PCT Finland	April 6, 1999 April 3, 1998	YES YES

We hereby claim the benefit of Title 35, United States Code §120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in a listed prior United States application in the manner provided by the first paragraph of Title 35, United States Code, §112, We acknowledge our duty to disclose any information material to the patentability of this application under 37 C.F.R. 1.56 which occurred between the filing date of the prior application and the national or PCT international filing date of this application:

Application No.	Filing Date	Status
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We hereby appoint John H. Mion, Reg. No. 18,879; Thomas J. Macpeak, Reg. No. 19,292; Robert J. Seas, Jr., Reg. No. 21,092; Darryl Mexic, Reg. No. 23,063; Robert V. Sloan, Reg. No. 22,775; Peter D. Olexy, Reg. No. 24,513; J. Frank Osha, Reg. No. 24,625; Waddell A. Biggart, Reg. No. 24,861; Louis Gubinsky, Reg. No. 24,835; Neil B. Siegel, Reg. No. 25,200; David J. Cushing, Reg. No. 28,703; John R. Inge, Reg. No. 26,916; Joseph J. Ruch, Jr., Reg. No. 26,577; Sheldon I. Landsman, Reg. No. 25,430; Richard C. Turner, Reg. No. 29,710; Howard L. Bernstein, Reg. No. 25,665; Alan J. Kasper, Reg. No. 25,426; Kenneth J. Burchfiel, Reg. No. 31,333; Gordon Kit, Reg. No. 30,764; Susan J. Mack, Reg. No. 30,951; Frank L. Bernstein, Reg. No. 31,484; Mark Boland, Reg. No. 32,197; William H. Mandir, Reg. No. 32,156; Scott M. Daniels, Reg. No. 32,562; Brian W. Hannon, Reg. No. 32,778; Abraham J. Rosner, Reg. No. 33,276; Bruce E. Kramer, Reg. No. 33,725; Paul F. Neils, Reg. No. 33,102; Brett S. Sylvester, Reg. No. 32,765; Robert M. Masters, Reg. No. 35,603 and George F. Lehnigk, Reg. No. 36,359, our attorneys to prosecute this application and to transact all business in the Patent and Trademark Office connected therewith, and request that all correspondence about the application be addressed to **SUGHRUE, MION, ZINN, MACPEAK & SEAS, PLLC, 2100 Pennsylvania Avenue, N.W., Washington, D.C. 20037-3213**.

We hereby declare that all statements made herein of our own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issuing thereon.

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